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Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/698,116	FLEURY ET AL.	
Examiner	Art Unit	_
Tamai IE Karl	2834	

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Subclass	Date	Examiner
43, 216, 156.28, 156.43,		
156.32,12		
179,180		
50, 40MM	6/15/2005	KIT
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	Subclass 43, 216, 156.28, 156.43, 156.32,12 179,180 50, 40MM	43, 216, 156.28, 156.43, 156.32,12 179,180 50, 40MM 6/15/2005

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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